



IFW

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Appl. No. : 10/816,948
Applicant : Rolf MEYER
Filed : April 5, 2004
TC/A.U. : 3731
Examiner : Not Yet Assigned

Docket No. : 1278-159
Customer No. : 06449
Confirmation No. : 2408

INFORMATION DISCLOSURE STATEMENT

Director of the United States Patent
and Trademark Office
P.O. Box 1450
Alexandria, Virginia 22313-1450

Dear Sir:

Under the provisions of 37 C.F.R. §§ 1.56, 1.97 and 1.98,
Applicant submits herewith a copy of the European Search Report and
information that the Office may wish to consider in examination of the
subject application. Materials submitted for consideration are listed
on the attached form PTO-1449.

Copies of the U.S. patent documents listed on the accompanying
1449 are not being furnished in accordance with the August 5, 2003 OG
notice of waiver of this requirement.

Respectfully submitted,

By G. F. Rothwell
G. Franklin Rothwell
Attorney for Applicants
Registration No. 18,125
ROTHWELL, FIGG, ERNST & MANBECK, p.c.
Suite 800, 1425 K Street, N.W.
Washington, D.C. 20005
Telephone: (202)783-6040

Enclosure(s): European Search Report (3 pages)
(6) Cited References

16 of -



INFORMATION DISCLOSURE STATEMENT BY APPLICANT

Complete if Known

Application Number	10/816,948
Filing Date	April 5, 2004
First Named Inventor	MEYER
Group Art Unit	3731
Examiner Name	Not Yet Assigned

Sheet	1	of	1	Attorney Docket Number	1278-159
-------	---	----	---	------------------------	----------

U.S. PATENT DOCUMENTS

Examiner Initials*	Cite No. ¹	U.S. Patent Document		Name of Patentee or Applicant of Cited Document	Date of Publication of Cited Document MM-DD-YYYY
		Number	Kind Code ² (if known)		
	1	5,304,182		RHEINISH et al.	04-19-1994
	2	5,499,987		FEINGOLD	03-19-1996
	3	5,643,276		ZALESKI	07-01-1997
	4	5,944,725		CICENAS et al.	08-31-1999
	5	6,143,001		BROWN et al.	11-07-2000
	6	6,336,932	B1	FIGUEROA et al.	01-08-2002
	7	6,371,960	B2	HEYMAN et al.	04-16-2002
	8	6,491,697	B1	CLARK et al.	12-10-2002
	9	6,497,708	B1	CUMMING	12-24-2002
	10	2002/0022881	A1	FIGUEROA et al.	02-21-2002

FOREIGN PATENT DOCUMENTS

Examiner Initials*	Cite No. ¹	Foreign Patent Document			Name of Patentee or Applicant of Cited Document	Date of Publication of Cited Document MM-DD-YYYY	T ⁶
		Office ³ Code	Number ⁴	Kind ⁵ (if known)			
	11	EP	1 287 791	A1	ANTON MEYER & CO. AG	03-05-2003	AB
	12	WO	95/13022	A1	IOVISION, INC.	05-18-1995	
	13	WO	96/03924	A1	CHIRON VISION CORPORATION	02-15-1996	
	14	WO	01/87186	A1	CORNEAL INDUSTRIE	11-22-2001	AB
	15	WO	02/058596	A2	ALLERGAN SALES, INC.	08-01-2002	
	16	WO	2004/010903	A1	DUCKWORTH & KENT LIMITED	02-05-2004	

Examiner
Signature

Date
Considered

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

¹Unique citation designation number. ²See attached Kinds of U.S. Patent Documents. ³Enter Office that issued the document, by the two-letter code.

⁴For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. ⁵Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST. 16 if possible. ⁶Applicant is to place a check mark here if English language translation is attached. AB indicates that only an English language abstract is attached.